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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,218	TSUTSUI, MIKIO	
Examiner	Art Unit	
John L. Goff	1733	

CEADCUED							
SEARCHED							
Subclass	Date	Examiner					
299,307.5, 307.7	1/25/2006	JLG					
	Subclass 299,307.5,	299,307.5,					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	1/25/2006	JLG		
Palm Inventor Search	1/25/2006	JLG		
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